

Notice of References Cited	Application/Control No. 10/028,402	Applicant(s)/Patent Under Reexamination CHEN ET AL	
	Examiner Nhon T. Diep	Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0026490	02-2003	Thyagarajan, Kadayam	382/244
*	B	US-2003/0118243	06-2003	Sezer et al.	382/245
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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